

RAA2P3226

High Speed Dual Coil Inductive Position Sensor ICs with UART ABI, Step/Dir and I2C Interfaces

RAA2P3226 product is a high-speed magnet-free, inductive position sensor ICs that can be used for absolute and incremental position sensing in industrial, medical, and consumer applications. The RAA2P3226 IC uses the physical principle of eddy currents to detect the position of a simple metallic target that is moving above a set of coils, consisting of one transmitter coil and two sets of receiver coils.

The coils are typically copper traces on a printed circuit board (PCB). The transmitter coil induces a secondary voltage in the receiver coils, which varies depending on the position of the metallic target above them.

A signal representative of the target's position relative to the coils is calculated by demodulating and processing the secondary voltages from the receiver coils. The target can be made of various metals, including aluminum, steel, or a PCB with a printed copper layer.

The device can achieve high positional accuracy, with up to 15-bit accuracy and 19-bit resolution, while operating at rotational speeds of up to 600000 rpm (electrical). An ultra-low propagation delay of less than 100ns provides high dynamic control for fast spinning motors.

The RAA2P3226 is equipped with:

- Up to 19-bit High-speed UART interface (up to 2Mbit/s)
- Up to 17-bit Incremental interfaces ABI and Step/Direction
- Dual 14-bit I2C interface (up to 400Kbit/s)

Available Support

Renesas provides application modules that demonstrate RAA2P3226 position sensing applications.

Typical Applications

- Optical and magnetic encoder replacement in robotics and industrial automation.
- Rotor position detection for BLDC motors with digital interfaces, adaptable to any pole pair count

Features

- Cost-effective; no magnet required
- Immune to magnetic stray fields; no shielding required
- Suitable for harsh environments and high temperatures
- Dual Coil inputs enabling high accuracy position sensing: up to 19-bit resolution, 15-bit accuracy
- True power-on position, obtained by UART, ABI, Step/Dir (Startup burst generator) or I2C
- Programmable through digital interface with UART or I2C
- Nonvolatile memory enables multiple programming options
- Single IC supports on-axis and off-axis rotation, linear motion, and arc motion sensing
- Adaptable to any full-scale angle range through coil design
- Overvoltage and reverse-polarity protection: ±18V on both supply and output pins
- Supply voltage programmable for 3.3V ±0.3V or 5.0V±0.5V
- 48 bits nonvolatile user ID memory space
- Qualified for industrial application use from -40°C to +125°C ambient temperature
- Small 16 TSSOP package (4.4mm x 5.0mm)

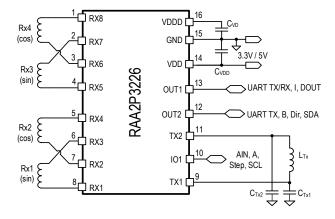


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1. Pin Assignments and Descriptions

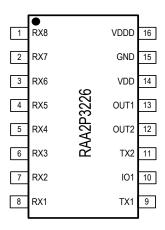


Figure 2. RAA2P3226 Pinout

Table 1. Pin Description

| Pin Number | Name | Туре | Description |
|------------|------|-----------------------------|---|
| 1 | RX8 | | Receiver coil set #2 (COS_N); secondary receiver coil |
| 2 | RX7 | 1 | Receiver coil set #2 (SIN_N); secondary receiver coil |
| 3 | RX6 | 1 | Receiver coil set #2 (COS); secondary receiver coil |
| 4 | RX5 | Concor Innut | Receiver coil set #2 (SIN); secondary receiver coil |
| 5 | RX4 | Sensor Input | Receiver coil set #1 (COS_N); primary receiver coil |
| 6 | RX3 | | Receiver coil set #1 (SIN_N); primary receiver coil |
| 7 | RX2 | | Receiver coil set #1 (COS); primary receiver coil |
| 8 | RX1 | | Receiver coil set #1 (SIN); primary receiver coil |
| 9 | TX1 | Transmitter Output | Connect the transmitter coil between the TX1 and TX2 pins, using series resistors R_{Tx1} and R_{Tx2} . The resonant frequency is adjusted with capacitors C_{Tx1} and C_{Tx2} from each coil terminal to GND |
| 10 | IO1 | Digital I/O Analog Input | I2C: SCL UART: Auxiliary Analog Input ABI: A Step/Dir: Step |
| 11 | TX2 | Transmitter Output | Connect the transmitter coil between the TX1 and TX2 pins, using series resistors R_{Tx1} and R_{Tx2} . The resonant frequency is adjusted with capacitors C_{Tx1} and C_{Tx2} from each coil terminal to GND |
| 12 | OUT2 | Digital I/O | I2C: SDA UART: TxD (2-wire) or Digital output ABI: B Step/Dir: Direction |
| 13 | OUT1 | Digital I/O | I2C: Digital output UART: Bi-directional TxD/RxD (1-wire), RxD input (2-wire) or inverted TxD. ABI: Index Step/Dir: Index Single Wire programming interface |
| 14 | VDD | Supply | External supply voltage (3.3V/5V) |
| 15 | GND | Supply | Common ground connection |
| 16 | VDDD | Supply | Internally regulated digital supply voltage. |
| | 1 | | 1 |

2. Specifications

2.1 Absolute Maximum Ratings

The absolute maximum ratings listed in Table 2 are stress ratings only. Exceeding these limits can cause permanent damage to the device. The functional operation of the RAA2P3226 at these maximum ratings is not guaranteed. Exposure to the absolute maximum rating conditions could impact device's reliability. All voltage levels are referred to GND.

Table 2. Absolute Maximum Ratings

| Symbol | Parameter | Conditions | Minimum | Maximum | Units |
|-------------------|--|--|---------|---------|-------|
| V_{VDDmax} | External supply voltage: VDD | | | | |
| V _{IO1} | Digital I/O pin voltage | O- mti | 40 | 40 | ., |
| V _{OUT2} | Digital I/O pin voltage | Continuous | -18 | 18 | V |
| V _{OUT1} | Digital output pin voltage | | | | |
| V _{RX1} | Sensor Receiver coil input pin voltage (RX1) | | | | |
| V_{RX2} | Sensor Receiver coil input pin voltage (RX2) | | | | |
| V _{RX3} | Sensor Receiver coil input pin voltage (RX3) | | | | |
| V_{RX4} | Sensor Receiver coil input pin voltage (RX4) | | | | |
| V_{RX5} | Sensor Receiver coil input pin voltage (RX5) | Continuous | -12 | 12 | V |
| V_{RX6} | Sensor Receiver coil input pin voltage (RX6) | | | | |
| V _{RX7} | Sensor Receiver coil input pin voltage (RX7) | | | | |
| V _{RX8} | Sensor Receiver coil input pin voltage (RX8) | | | | |
| V_{Tx1} | Transmitter pin (TX1) voltage | Continuous | 0.2 | F F | V |
| V _{Tx2} | Transmitter pin (TX2) voltage | Continuous | -0.3 | 5.5 | V |
| $V_{VDDDmax}$ | Internal digital supply voltage, VDDD | VDDD is internally regulated with external capacitor to GND. | -0.3 | 2.0 | V |
| Т _{АМВ} | Ambient temperature | | -40 | 125 | °C |
| T_J | Junction temperature | | -40 | 135 | °C |
| T _{STOR} | Storage temperature | Unmounted units must be limited to 10 hours at temperatures above 125°C to prevent pre-aging | -55 | 160 | °C |
| R _{THJA} | Thermal resistance junction to ambient: 16-TSSOP package | Velocity = 0m/s with 2s2p PCB test board (JEDEC 51-2, JEDEC 51-7) | | 89.5 | K/W |
| R _{THJC} | Thermal resistance junction to case: 16-TSSOP package | Junction to top of package | | 38.38 | K/W |

2.2 ESD Ratings

Table 3. ESD Ratings

| Symbol | Parameter | Conditions | Maximum | Units |
|------------------|---|---|---------|-------|
| V _{ESD} | ESD tolerance for all pins Human Body Model: 100pF/1.5kΩ | According to JEDEC JS-001, classification 2 | ±2 | kV |
| V _{CDM} | ESD tolerance for all pins. Charged-Device Model (CDM) | According to JEDEC JS-002, classification C2b | ±750 | V |

2.3 Operating Conditions

All minimum/maximum specification limits are guaranteed by design, production testing, and/or statistical characterization. Conditions: $T_{AMB} = -40$ °C to 125°C unless otherwise specified. $C_{VDD} = 470$ nF, $C_{VDDD} = 100$ nF.

Typical values are based on characterization results at default measurement conditions and are informative only.

Table 4. Electrical Characteristics, 5V and 3.3V Modes

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|-------------------------|---|--|---------|---------|---------|-------|
| V _{VDD5} | Supply voltage, 5V mode | | 4.5 | 5.0 | 5.5 | V |
| V5 _{UV} | Undervoltage detection level, 5V mode | An under-voltage alarm is created if VDD falls below this limit | 3.95 | 4.1 | 4.45 | V |
| V5 _{OV} | Overvoltage detection level, 5V mode | An overvoltage alarm is created if VDD rises above this limit | 5.55 | 6.15 | 6.5 | V |
| V_{VDD3} | Supply voltage, 3.3V mode | | 3.0 | 3.3 | 3.6 | V |
| V3 _{UV} | Undervoltage detection level, 3.3V mode | An under-voltage alarm is created if VDD falls below this limit | 2.7 | 2.8 | 2.98 | V |
| V3 _{ov} | Overvoltage detection level, 3.3V mode | An overvoltage alarm is created if VDD rises above this limit | 3.65 | 3.85 | 4.04 | V |
| V _{VDD_TH_} H | Power-on reset (POR), high threshold | Power-on reset (POR): the device is activated when VDD increases above this threshold | | 2.61 | 2.7 | V |
| V _{VDD_TH_L} | Power-on reset, low threshold | The device is deactivated when VDD decreases below this threshold | 2.3 | 2.38 | | V |
| V _{DDPOR_HYST} | Power-on reset hysteresis | | 200 | 250 | 300 | mV |
| t _{stup PE} | Start up time | Power-on reset (POR) to valid output signal, programming enabled | | | 5 | ms |
| t _{stup PL} | Start-up time | Power-on reset (POR) to valid output signal, programming locked | | | 3 | ms |
| t _{stup cmd} | Command timeout time | Time to wait before sending first command | 1.5 | | | ms |
| t _{ProgEn} | Programming window enable time | Timeout window after POR, in which a first programming enable command must be sent | | | 5 | ms |
| t _{ProgUL} | Programming window unlock time | Timeout window after programming enable in which a second unlock command must be completely sent | | | 75 | ms |

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|-------------------------|---------------------------------------|--|---------|---------|---------|-------|
| V_{VDDD} | Digital supply voltage | Internally regulated. Connect capacitor C _{VDDD} = 100nF from VDDD to GND | 1.75 | 1.8 | 1.85 | V |
| I _{AUXIN} | VDDD external load current | VDDD must be connected to a capacitor C _{VDDD} . | 0 | | 4 | mA |
| I _{SHORT VDDD} | VDDD short circuit current limitation | | 18.5 | 27 | 40 | mA |
| Icc | Current consumption | Without coils, no load | 10 | 15 | 20 | mA |
| C_{VDDD} | Capacitor from VDDD pin to GND | | 100 | | | nF |
| C_{VDD} | Capacitor from VDD pin to GND | Nominal value | 100 | 470 | | nF |

Table 5. Position Resolution and Update Rate

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|------------------------|--|--|---------|-----------------------------|---------|-------|
| RES _{I2C} | Position Resolution I2C Interface | | | 14 | | bit |
| RES _{UART} | Position Resolution UART Interface | | | 14 | | bit |
| RES _{INC_BIN} | Position Resolution Incremental Interfaces (ABI,Step/Dir) | Binary Mode Counts per 1 coil period (programmable) | | 512 1024 2048 4096 | | cpr |
| RES _{INC_DEC} | | Decimal Mode Counts per 1 coil period (programmable) | | 500 1000 2000 4000 | | cpr |
| ACC | Position Accuracy UART, ABI (12-bit), Step/Dir (12-bit), I2C | Ambient Temperature, Nominal Supply | -0.1 | | 0.1 | %FS |
| ACC | | Over temperature and supply range | -0.2 | | 0.2 | %FS |
| t _{POS} | Position refresh rate | Internal Refresh rate of position information | 4 | | 6 | μs |

Table 6. Non-volatile Memory Parameters [1]

| Parameter | Conditions | Minimum | Typical | Maximum | Units |
|-------------------|---|-------------------------------|-----------------------------|---------|---------------------|
| Data retention | Qualified according to JEDEC 22-A117 | 15 @T _J = 100°C | | | Years |
| Data retention | Over product lifetime | | >100 @T _J = 25°C | | Tours |
| Write temperature | Allowed ambient temperature | -40 | | 125 | °C |
| Read temperature | range for read and write access | -40 | | 125 | °C |
| Endurance [2] | Over product lifetime | | | 1000 | NVM Write Cycles |
| Read Cycles | Over product lifetime | 5x 10 ¹¹ | 1x 10 ¹² | | NVM Read events |

^[1] Guaranteed by memory supplier

^[2] Verified number of program/erase cycles. Qualified with 2000 cycles.

Table 7. LC Oscillator Specifications

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|-------------------------------------|---|--|---------|---------|----------------------|-------|
| f _{LC} | Excitation frequency | LC oscillator frequency is determined by external components L and C | 2 | | 5.5 | MHz |
| R _{Peq} | Equivalent parallel resistance of the LC resonant circuit | | 250 | | | Ω |
| V | LC oscillator amplitude at VDD = 5.0V ±10% | Peak-to-peak voltage; pins TX1 vs. TX2; all modes. Adjustable by | | | 8.8 | Van |
| V _{TX_PP} | LC oscillator amplitude at VDD = 3.3V ±10% | coil current. | | | 2* V _{VDD3} | Vpp |
| I _{LC} | Programmable transmitter coil drive current | T _{ambient} = -40 to +125°C | 0 | [1] | 16 | mA |
| R _{Tx1} , R _{Tx2} | LC oscillator series resistors | Depending on coil design and excitation frequency (f _{LC}) | | 10 | | Ω |

^[1] The required transmitter coil current is determined by the equivalent parallel resistance of the LC circuit, depending on coil design.

Table 8. Receiver Coils Front-End Specifications

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|--------------------------------------|---------------------------------------|--|---------|---------|---------|-----------|
| V_{RX} | RX coil amplitude | Differential coil input | 5 | | 200 | mV_{pp} |
| A _{IN_mm} | Maximum amplitude mismatch correction | Programmable gain mismatch correction of RX coil signals (SIN and COS) | | | 15 | % |
| Ain_offs_range% | Input offset correction range | Differential input offsets of sine or cosine signal, percentage of transmitter coil amplitude. | -0.2 | | 0.2 | % |
| Doffset | Coil input offset temperature drift | Over temperature range T _{AMB} | -2.5 | | 2.5 | % |
| C _{RX1} to C _{RX8} | Receiver input filter capacitors | For improved EMC immunity | | 220 | | pF |
| Noisesp | Signal path noise level | Digital filtering = OFF V _{RX} = 50mV | | | 0.1 | ° el. rms |
| ΝΟΙΘΕΣΡ | | Digital filtering = OFF V _{RX} = 5mV | | | 0.5 | ° el. rms |

2.4 Interface Pin Characteristics

Table 9. UART Interface

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|--------------------------|---|---|--------------|---------|-----------|-------|
| V _{OL_UART} | Output low voltage | 3mA sink current, VDD = 3.0 to 5.5V OUT1 pin 13 OUT2 pin 12 | | 0.4 | V | |
| V _{OH_UART} | Output high voltage | 3mA source current, VDD = 3.0 to 5.5V OUT1 pin 13 OUT2 pin 12 (Push-Pull condition) | 0.8 × VDD | | VDD | ٧ |
| IOUT2 lim thr | OUT2 current limitation threshold | OUT2 pin 12 | 8 | | | mA |
| I _{OUT2 sc lim} | OUT2 output short current limitation ^[1] | OUT2 pin 12 Short to VDD, GND VDD = 3.0 to 5.5V Open Drain mode | 14 | | 26 | mA |
| IOUT1 lim thr | OUT1 current limitation threshold | OUT1 pin 13 | 35 | | | mA |
| I _{OUT1} sc lim | OUT1 output short current limitation ^[2] | OUT1 pin 13 Short to VDD, GND VDD = 3.0 to 5.5V Push-pull mode | 28 | | | mA |
| I _{OUT1 sc lim} | OUT1 output short current limitation ^[2] | OUT1 pin 13 Short to VDD, GND VDD = 3.0 to 5.5V Open Drain mode | 28 | | 56 | mA |
| | OUT1 low level | VDD = 5V | -0.3 | | 0.2 × VDD | V |
| V_{IL_UART} | input voltage | VDD = 3.3V | -0.3 | | 0.3 × VDD | V |
| V | OUT1 high level input | VDD = 5V | 0.7 × VDD | | VDD + 0.3 | V |
| V _{IH_UART} | voltage | VDD = 3.3V | 0.7 × VDD | | VDD + 0.3 | V |

^[1] With OUT2 drive strength set to "00" and OUT2 drive strength for open drain disabled. (out2_io1_drv = "00")

Table 10. I2C Specifications

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|-------------------------------------|--|------------------|----------|---------|----------|--------|
| f _{I2C} | I2C clock rate | | | | 400 | Kbit/s |
| t _{SCL_LOW} | Low level state of SCL | Normal mode | 4.7 | | | μs |
| | clock | Fast mode | 1.3 | | | μs |
| t _{SCL_HIGH} | High level state of SCL | Normal mode | 4.0 | | | μs |
| | clock | Fast mode | 0.6 | | | μs |
| t _{R_SDA_SCL} | Rise time of SDA/SCL | Normal mode | | | 1000 | ns |
| | (30% to 70%) $R_{SDA/SCL}=2k\Omega$ | Fast mode | 20 | | 300 | ns |
| t _{F_SDA_SCL} | Fall time of SDA/SCL | Normal mode | 20 | | 300 | ns |
| (70% to 30%) $R_{SDA/SCL}=2k\Omega$ | | Fast mode | 20 | | | ns |
| V _{IH_I2C} | High level input voltage | SCL clock input, | 0.7× VDD | | VDD+0.5 | V |
| V _{IL_I2C} | Low level input voltage | SDA data input | -0.5 | | 0.3× VDD | V |

^[2] With digital mode configuration (out1_drv="10")

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|--|--|--|---------------|---------|---------|-------|
| | | DIN, ADR0, ADR1 | | | | |
| V _{I2C_hyst} | Hysteresis of Schmitt trigger input | SCL clock input SDA, DIN, ADR0, ADR1 | SDA, DIN, VDD | | | V |
| I _{LEAK} | Input leakage current | VDD = 0V to 5.5V | -10 | | 10 | μА |
| I _{SDA lim thr} | SDA current limitation threshold | OUT2 pin 12 (SDA) | 8 | | | mA |
| I _{SDA sc lim} | SDA output short current limitation ^[1] | Short to VDD, GND VDD = 3.3V, 5V | 14 | | 26 | mA |
| V_{OL_SDA} | Output low voltage SDA low level output voltage open drain | 3mA sink current VDD = 3.0 to 5.5V | 0 | | 0.4 | V |
| l _{OL} | Low level output current | V_{OL} = 0.4V, VDD = 5.5V, $R_{SDA/SCL}$ = 2k Ω | 3 | | | mA |
| t _{SP} | Input spike suppression | Spikes shorter than t _{SP} are suppressed | 400 | | 426 | ns |
| Св | External capacitive load for each bus line | | | | 400 | pF |
| R _{SDA} , R _{SCL} | External pull-up resistor at pins SDA and SCL | Resistor value and capacitive load on these pins are limiting the maximum clock frequency | 1.8 | 4.7 | | kΩ |
| R_{ADR} | External resistor at pin ADR for I2C address selection | Pull-up/pull- down, depending on I2C address setting. | 1.8 | 4.7 | | kΩ |
| I _{DOUT lim thr} I2C | DOUT current limitation threshold ^[2] | OUT1 pin 13 in overload condition | 35 | | 56 | mA |
| I _{DOUT sc lim I2C} | DOUT output short current limitation ^[2] | OUT1 pin 13 | 28 | | 58 | mA |

^[1] With OUT2 drive strength set to "00" and OUT2 drive strength for open drain disabled. (out2_io1_drv = "00")

Table 11. Incremental Interfaces Specifications

| Symbol | Parameter | Description | Minimum | Typical | Maximum | Units |
|---------------------|---------------------------------------|--|-----------|---------|---------|-------|
| f _{inc} | Single channel Pulse Rate | ABI Step/Dir interfaces | | | 2 | MHz |
| V _{OH_inc} | Output high voltage ABI -Step /Dir | 3mA source current, VDD = 3.0 to 5.5V Pin 13 (OUT1) Pin 12 (OUT2) Pin 10 (IO1) | 0 | | 0.4 | V |
| V _{OL_inc} | Output low voltage ABI -Step /Dir | 3mA sink current, VDD = 3.0 to 5.5V Pin 13 (OUT1) Pin 12 (OUT2) Pin 10 (IO1) | 0.8 × VDD | | VDD | V |

^[2] With digital mode configuration (out1_drv="10")

RAA2P3226 Datasheet

| Symbol | Symbol Parameter Description | | Minimum | Typical | Maximum | Units |
|-------------------------------|---|--|-----------------------------|---------|---------|-------|
| I _{OUT2} IO1 lim thr | Current limitation threshold A,B / Step, Dir pins | Pin 12 (OUT2) Pin 10 (IO1) in overload condition | 6 | | | mA |
| I _{OUT2} IO1 sc lim | Output short current limitation [1] A,B / Step, Dir pins | Pin 12 (OUT2) Pin 10 (IO1) Short to VDD / GND VDD = 3.3V,5V | 10 (IO1) rt to VDD / GND | | | mA |
| I _{OUT1 lim thr} | Current limitation threshold ^[1] Index pin | Pin 13 (OUT1) in overload condition | 35 | | | mA |
| OUT1 sc lim | Output short current limitation [1] Index pin | Pin 13 (OUT1) Short to VDD / GND VDD = 3.3V,5V | 28 | | 58 | mA |
| t _{r_local} | Output rising edge embedded applications | Load capacitance 60pF Output voltage rising from 10% to 90% VDD = 3.0 to 5.5V | | | 55 | ns |
| t _{f local} | Output falling edge, embedded applications | Load capacitance 60pF Output voltage falling from 90% to 10% VDD = 3.0 to 5.5V | | | 55 | ns |
| t _{r remote} | Output rising edge remote applications | Load capacitance 4.7nF Output voltage rising from 10% to 90% VDD = 3.0 to 5.5V | | | 4 | us |
| t _{f remote} | Output falling edge remote applications | Load capacitance 4.7nF Output voltage falling from 90% to 10% VDD = 3.0 to 5.5V | | | 4 | us |

^[1] With digital mode configuration (out1_drv="10").

^[2] With OUT2 fast configuration (out2_io1_drv="11")

3. Detailed Description

3.1 Overview

The RAA2P3226 sensor IC consists of one transmitter coil and two pairs of receiver coils, which are typically designed as traces on a printed circuit board. The receiver coils are designed as two wire loops with anti-serial connection. The "sine" coil and the "cosine" coil are shifted by 90 electrical degrees. A metal target is placed above the coil arrangement.

RAA2P3226 IC supports two sets of independent receiver coils enabling dual track high resolution designs.

When the IC drives an AC current into the transmitter coil, it generates an alternating magnetic field. This magnetic field induces secondary voltages in the receiver coils. Without a target, the induced voltages in the loops of the receiver coils cancel each other out, resulting in a net receiver voltage of zero.

When a metal target is placed above the coils, the magnetic field generates eddy currents on its surface. These eddy currents create a counter magnetic field, reducing the total flux density underneath. This leads to a reduction in the voltage induced in the receiver coil areas underneath the target, creating an imbalance in the anti-serial coil segment voltages.

For every channel, the IC demodulates, offsets and corrects the amplitude of the signals from the two receiver coils with a 90° electrical phase shift design, which generates sine and cosine shaped voltages as the target is moving

The RAA2P3226 IC amplifies, rectifies, and filters the receiver voltages, converting them into digital representation with an ADC. The digital sine and cosine signals from the two channels are converted into a 0° to 360° absolute position. The signal accuracy can be further enhanced through a 2-dimentional,16-point linearization process.

The absolute position can be read in digital format by UART, ABI, Step/Dir or I2C interface.

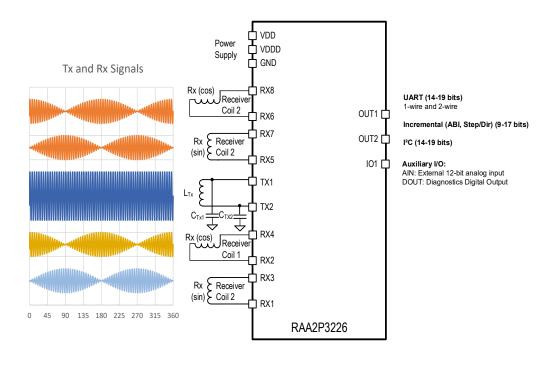


Figure 3. RAA2P3226 Input/Output Signals

3.2 Block Diagram

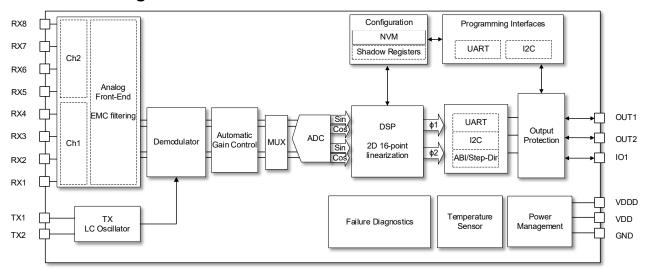


Figure 4. Block Diagram

The main building blocks include:

- Analog front-end: Input filter, offset, and gain control for the receiver signals.
- Input Multiplexer: Sequential selects the different receiver coils and other test signals for further signal processing.
- Demodulator: Converts RF modulated position signal to LF demodulated raw sine and cosine signals.
- Automatic Gain Control: Automatically adjusts raw sine and cosine signal levels.
- MUX: Multiplexer for ADC input.
- High Speed ADC: Converts raw signals into digital format for further processing.
- Digital signal processing: Converts digital sine and cosine raw signals into synchronized absolute position information.
- 2D 16-point linearization: Supports up to 16 two-dimensional linearization points with freely programmable Xand Y- coordinates for each point (X= Position input, Y= Position output).
- Digital Interfaces: Post processing, Delay correction, speed calculation, clamping, signal integrity checks.
 Decoding of Channel 1 and Channel 2 information and other diagnostics info into the selected output format (UART, ABI, Step/Dir or I2C).
- TX Oscillator: Generates the transmitter coil signal.
- Temperature sensor: Internal temperature sensor used for chip diagnostics.
- Protection: All outputs are fully protected against overvoltage, reverse polarity and short circuit, enabling direct cable connection to these outputs and eliminating the need for additional line driver ICs.
- Power Management: Operates with supply voltages ranging from 3.0V to 5.5V. External capacitors are
 required for the supply voltage VDD, and for the digital power supply, VDDD. All other supplies, such as the
 supply for the analog circuits do not need any external capacitor.
- Programming interface: Accessible via single-wire interface, based on a half-duplex UART protocol. If the I2C interface is selected, the NVM programming can also be performed by the I2C interface.
- Configuration, NVM: Stores non-volatile storage for factory and user-programmable settings. User configuration parameters can be programmed multiple times.
- On-chip failure diagnostics: Performs internal diagnosis of critical blocks.
- Auxiliary I/O including AIN (12-bit analog input for external analog signals), DOUT (Diagnostic Output) readable over I2C interfaces.

3.3 LC Oscillator

The transmitter circuit of the RAA2P3226 generates the required RF magnetic field for operating the sensor as determined by an external parallel LC circuit, see Figure 5. To ensure low emission of harmonics, the capacitive part of the LC circuit is split into two equal-value capacitors: CTx1 and CTx2. Additionally, two series resistors RTx1 and RTx2 are added as shown in Figure 5.

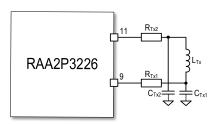


Figure 5. TX LC Oscillator Connection

3.3.1 Parallel LC Resonator Calculations

A resonator, comprising an inductor (L) and a capacitor (C) in parallel, is essential for generating specific frequencies in RF applications. Accurate calculations of the equivalent parallel resistance (R-Peq) ensure proper resonator function. In the RAA2P3226 transmitter circuit, this resonator minimizes harmonic emissions.

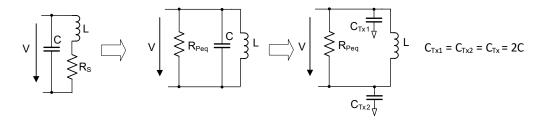


Figure 6. Parallel Resonator Circuit

Equivalent parallel resistance from Coil series resistance:

$$R_{Peq} = \frac{1}{R_S} \times \frac{L}{C}$$

Equation 1

For
$$C_{Tx1} = C_{Tx2} = C_{Tx} = 2C$$
:

$$R_{Peq} = \frac{1}{R_S} \times \frac{2 \times L}{C_{Tx}}$$

Equation 2

Equivalent parallel resistance from Quality factor Q:

$$R_{Peq} = Q \times \sqrt{\frac{L}{C}} = Q \times \sqrt{\frac{2L}{C_{Tx}}}$$

Equation 3

Ideal LC Oscillator frequency with split Tx capacitors C_{Tx}

$$f_{TX} = \frac{1}{2\pi \sqrt{L\frac{C_{Tx}}{2}}}$$

Equation 4

Oscillator frequency with split Tx capacitor C_{Tx} and coil series resistor R_s

$$f_{TX} = \frac{1}{2\pi} \sqrt{\frac{2}{LC_{TX}} - \left(\frac{R_S}{L}\right)^2}$$

Equation 5

Oscillator frequency with split Tx capacitor C_{Tx} and equivalent parallel resistor R_{Peq}

$$f_{TX} = \frac{1}{2\pi} \sqrt{\frac{2}{LC_{TX}} - \left(\frac{2}{R_{Peq}C_{TX}}\right)^2}$$

Equation 6

$$Q = R_{Peq} \sqrt{\frac{C}{L}} = \frac{1}{R_S} \sqrt{\frac{L}{C}}$$

Equation 7

Coil quality factor

$$Q = \omega \frac{L}{R_S} = 2\pi f_{TX} \frac{L}{R_S}$$

Equation 8

Where:

R_{Peq} Equivalent parallel resistance of the LC circuit at the transmitter frequency in Ohms

Rs Serial resistance of the transmitter coil at the transmitter frequency in Ohms

 f_{Tx} Resonant circuit frequency in Hertz, 1/s

L Resonant circuit coil impedance in Henry

C Resonant circuit capacitance in Farad

 C_{Tx1} , C_{Tx2} Capacitance of the split capacitors in Farad

 $Q \qquad \qquad \text{Resonant circuit quality factor (unitless)} \\ ω \qquad \qquad \text{Angular frequency } 2^*π^*f_{Tx} \text{ in Hertz, 1/s}$

3.4 Coil Design

Figure 7 shows an example of a linear motion sensor with one transmitter coil (transmitter loop) and two receiver coils (Sin loop and Cos loop). Due to the alternating clockwise and counterclockwise winding direction of each segment in a loop (for example RxCos = clockwise Cos Loop1 + counterclockwise Cos Loop2), the induced voltages in each segment have alternating opposite polarity.

Equation 9

 $V_{\text{Cos Loop1}} = -V_{\text{Cos Loop2}}$

If no target is present, the secondary voltages cancel each other:

$$V_{\text{Cos}} = V_{\text{Cos Loop1}} - V_{\text{Cos Loop2}} = 0V$$
 Equation 10

With a target placed above the coils, the secondary voltage induced in the covered area is lower than the secondary voltage without a target above it.

VCos Loop1 ≠ -VCos Loop2 Equation 11

This creates an imbalance of the secondary voltage segments, and thus, a secondary voltage ≠ 0V is generated, depending on the location of the target.

 $V_{Cos} = V_{Cos Loop1} - V_{Cos Loop2} \neq 0V$ Equation 12

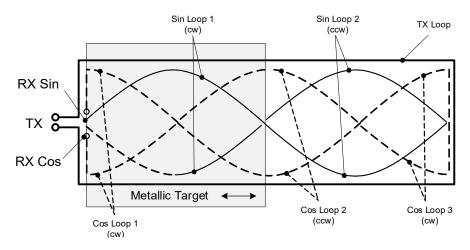


Figure 7. Coil Design for a Linear Motion Sensor

The same principles shown for the linear motion sensor can be applied to a rotary sensor as shown in Figure 8.

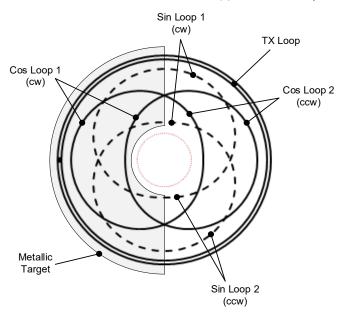


Figure 8. Coil Design for a 360° Rotary Sensor

3.4.1 Multi-periodic Coil Design Application Examples

Applying the same fundamental design principles, coils with multiple periods per turn can be designed. Multiperiodic designs improve mechanical accuracy compared to single-periodic coil designs. For example, a 4-periodic coil design (4 × 90°) improves mechanical accuracy by a factor of 4. Consequently, for angular designs, requiring < 360° movement range, coil designs with multiple periods are recommended. They not only improve mechanical accuracy, but such designs are also more robust towards mechanical target misalignment and tilt.

3.4.2 Electrical versus Mechanical Degrees

The RAA2P3226 converts the movement of a target across a single period of the receiver coil into a precise electrical signal. This conversion spans the full angular range from 0°to 360°, producing a digital output ranging from 0 to (2^N-1) LSBs. The position output is thus absolute over a full turn of 360 mechanical degrees. As illustrated in Figure 9, the single-periodic coil design establishes a direct 1:1 relationship between electrical and mechanical domains as the following:

Coil Period: 360° electrical

Mechanical Range: 360° mechanical

Conversion Factor: 1:1 (1°el. = 1° mechanical)

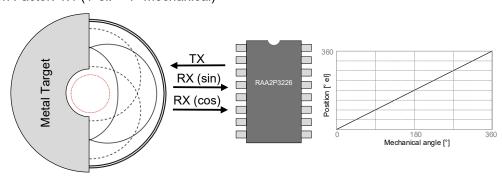


Figure 9. Coil Design Using 1-periodic Coil

As illustrated in Figure 10, a coil design with four receiver coil periods within a single full mechanical turn, results in four electrical rotations for every complete mechanical turn and provides the following advantages in accuracy and resolution.

 Higher Resolution: Position output resolution increases proportionally with period count by Mechanical Resolution = Sensors Periods * Electrical Resolution

In this configuration one electrical degree (°el) equals 0.25 mechanical degrees (°). The provided output resolution is four times higher compared to the single-periodic design.

Improved accuracy: Mechanical error is reduced by the period factor

$$\textit{Mechanical Error} = \frac{\textit{Electrical Error}}{\textit{Sensor Periods}}$$

This configuration is particularly well-suited for:

- Multi-pole motors requiring precise commutation
- Limited-range applications (<180° mechanical travel)
- Systems demanding high-resolution incremental feedback

Select the number of periods based on application requirements to optimize measurement performance. Proper period selection is critical for achieving maximum system accuracy.

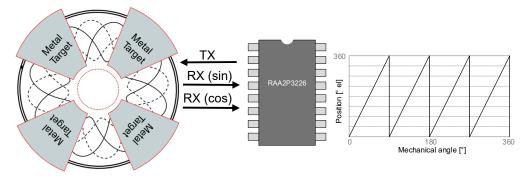


Figure 10. Coil Design Using 4-periodic Coil

3.4.3 Dual Coil High Resolution Mode

The RAA2P3226 is capable of handling two different sets of receiver coils and can be configured in high resolution mode. By defining a specific combination of receiver coils with a varying number of pole pairs on the primary and secondary receivers, the device can calculate position information with high accuracy. The primary coil features multiple periods, while the secondary coil serves as a reference track to identify the correct period of the primary. Two high resolution configurations are available: one track mode or Vernier mode. See Table 12 for configuration options and the resulting resolution.

| High Resolution Mode | Primary Coil [periods] | Secondary Coil [periods] | Resolution [bits] |
|----------------------|------------------------|-----------------------------|----------------------|
| One Track Mode | 4 | | 16 |
| | 8 | , [| 17 |
| | 16 | ' | 18 |
| | 32 | | 19 |
| Vernier Mode | 4 | 3 | 16 |
| | 8 | 7 | 17 |
| | 16 | 15 | 18 |
| | 32 | 31 | 19 |

Table 12. High Resolution Modes

By configuring the primary coil to 32 pole pairs, the device reaches its highest achievable resolution: 19 bits for UART and I2C. The maximum achievable resolution on ABI interface is 17-bit and it is provided by configuring 32 periods on the primary coil.

The high-resolution data is stored in two separate registers (hires_lsb 0x028A, hires_msb 0x028C). To ensure the data is consistently and accurately latched, it is essential to access the LSB first, followed by the MSB. Accessing the LSB via the digital interfaces (UART, I2C) freezes the MSB information automatically.

3.4.3.1 One Periodic Reference Track Mode

In this mode, the primary coil can be configured with 4,8,16 or 32 number of periods. The secondary coil serves as a reference track with a single pole pair, see Figure 11.

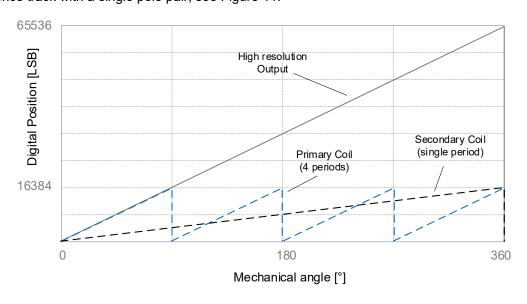


Figure 11. One Track Mode with Single Periodic Reference Track

3.4.3.2 Vernier Reference Track Mode

In Vernier reference track mode, the primary is configured to have 4,8,16 or 32 periods, while the secondary coil has one period less than the primary (3,7,15,31), see Figure 12.

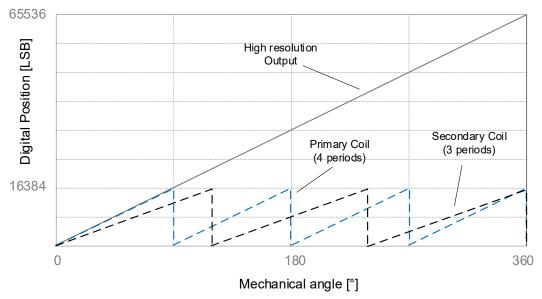


Figure 12. High Resolution Mode with Vernier Configuration

3.4.3.3 Coil Synchronization

Ensuring zero position synchronization between the primary and secondary coils is critical to avoid sudden jumps in the output position. The maximum allowable shift between the zero positions of the primary and secondary coils depends on the selected configuration for primary coils, as detailed in Table 13.

| Symbol | Parameter | Conditions | Minimum | Typical | Maximum | Units |
|-------------------|---|--|------------|---------|-----------|--|
| Z _{Sync} | Zero position shift between primary and | One periodic reference highres_mode=N, 1 | -180 | | 180 | °electrical of primary coil period |
| | secondary coil. | Vernier reference highres_mode=N, N-1 | -180/(N-1) | | 180/(N-1) | °electrical of primary coil |

Table 13. High Resolution Coil Synchronization

4. Linearization

The RAA2P3226 offers a very flexible linearization feature to enhance sensor accuracy. The linearization algorithm is applied digitally after the angle calculation. The linearization is performed with 16-bits resolution over a 360° electrical range (el.). Up to 16 programmable linearization points can be positioned within a grid of 0.088° in both X (position) and Y (expected output) directions and must be shared between primary and secondary coils.

Figure 13 illustrates an example of the impact of linearization, showing that the total error is significantly reduced.

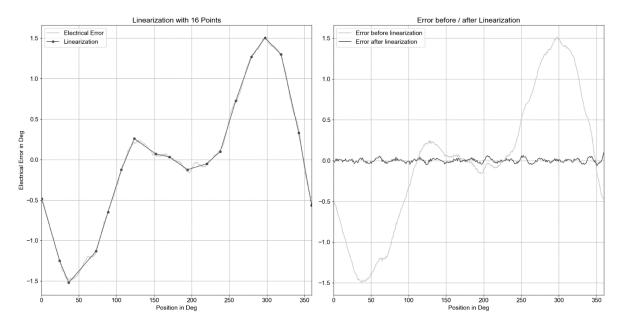


Figure 13. Example of a 16-point Linearization

Conditions Units Symbol **Parameter** Minimum **Typical** Maximum Number of linearization points N_{P_Lin} 16 **Grid**_{LIN} Placement grid of linearization points In X and Y 0.088 °el X and Y Resolution of linearization transfer function 12 Res_{l in} bits coordinates

Table 14. Linearization Parameters

Note: The slope of each segment $(\Delta Y / \Delta X)$ is automatically calculated from the X and Y parameters of adjacent linearization points. If two adjacent points are positioned with a slope outside the specified range (see Table 14), the slope is reset to 0 to prevent an overflow of the calculated slope value.

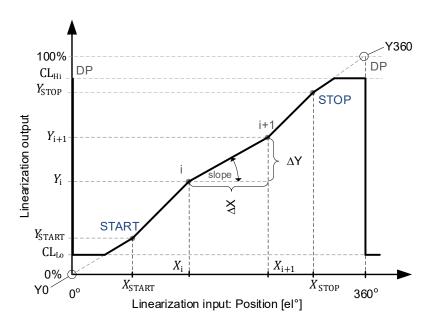


Figure 14. Linearization Transfer Function Parameters

Table 15. Linearization Parameter Settings

| Parameter | Description | Programming Options | Resolution |
|--------------------|---|---|--------------------|
| P _{Lin} | Number of total linearization options [1] | Up to 16 points can be assigned to the primary and secondary coils in multiple combinations | |
| D _P | Discontinuity point, Zero position transition from 0°/360° | | |
| X _{Start} | Mechanical start position, first linearization point | | |
| Y _{Start} | Expected output at XStart, first linearization point | | 0.088°el. / LSB |
| X _i | Mechanical position of linearization point (i =1 to 16, including start and stop) | 0° to <360° el. | |
| Yi | Expected output at linearization point (i =1 to 16 including start and stop) | | |
| X _{Stop} | Mechanical end position, last linearization point | | |
| Y _{Stop} | Expected output at XStop, last linearization point | | |
| CL _{Hi} | Output Clamping level, high | 0% to 100% VDD | 12 bits |
| CL _{Lo} | Output Clamping level, low | 0 /0 (0 100 /0 VDD | (VDD / 4096) / LSB |
| Y0 | Position at DP, start value at X=0° | 0° / 360° el. | |
| Y360 | Position at DP, stop value at X=360° | 0° / 360° el. | |

^[1] Up to 16 Linearization points can be shared between both coil sets. Several options are possible, for example, 8+8 configuration reserves 8 linearization points for the primary coil and 8 points for the secondary. For more information, see the *RAA2P3226 Programming Manual* document.

5. Interfaces

The RAA2P3226 offers an UART interface operating at up to 2Mbit/s and an I2C that can reach 400 KHz. A summary of the maximum speed for each high-speed interface is shown in Table 16.

| Interfaces | Number of I/f Wires | Resolution | Features | Other options |
|-----------------------|------------------------|------------|---|---|
| UART | 1 or 2 | 14-19 bit | ■ Speed ≤600 krpm, max. 2Mbit/s 92-bit frame, ≤21.7kHz frame rate (1 register read/write, 2 registers fast read) | Half duplex, 1 or 2 wire interface, Supporting parallel connection up to 4 slaves, Auto baud rate adaptation Digital Output (pin 12) (single wire only) Analog Input (pin 10) |
| ABI Step/Direction | 3 | 9-17 bit | Maximum. edge rate = 8MHzSee Table 26 | Configurable binary and decimal based resolution |
| I2C | 2 | 2 x 14 bit | Interface speed: 400KHzPosition update rate: 2.7 KHz | Digital output (pin 13) |

Table 16. Interfaces Overview

5.1 High Speed UART Interface

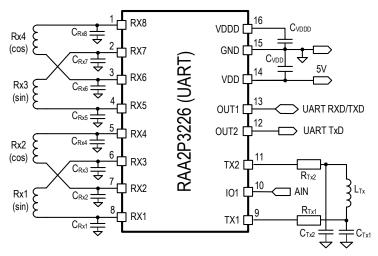


Figure 15. UART Interface with Dual Coil Input/Output Pins

The UART interface can be configured in the following modes:

- single wire bidirectional
- dual wire unidirectional
- dual wire differential bidirectional

Note: all UART modes operate in half duplex data transmission.

 Operating Mode
 OUT1 (Pin 13)
 OUT2 (Pin 12)

 Single wire bidirectional
 RxD/TxD
 Not Used

 Dual wire unidirectional
 RxD/TxD complementary
 TxD

 Dual wire differential bidirectional
 RxD
 TxD

Table 17. UART Operation Modes

| UART Programming Parameter | Number of Options | Programming Option | | | |
|----------------------------|-------------------------|---|--|--|--|
| UART output drive | 2 | Open drain or push-pull | | | |
| UART slave address | 4 | 2 LSBs of general slave address | | | |
| UART Baud rate [1] | 6 | {9600, 57600, 115200, 230400,1M,2M} bit/sec | | | |
| UART operation mode | 3 | See Table 17 | | | |
| UART error warnings | 7 | Baud rate, framing, CRC errors | | | |

Table 18. UART Interface User Programming Options

5.1.1 Single Wire Bidirectional UART

In single wire UART mode, the device communicates with the ECU using only OUT1 pin, which can be configured in either push-pull or open drain mode. This mode is suitable for point-to-point connections where one device interfaces directly with an ECU (Figure 16) or for implementing a multi-slave single bidirectional wire connection. (Figure 17).

In open drain mode, a single Master can address up to four sensors over a single wire, communicating with one sensor at a time. Each sensor is identified by its slave address, stored in the NVM.

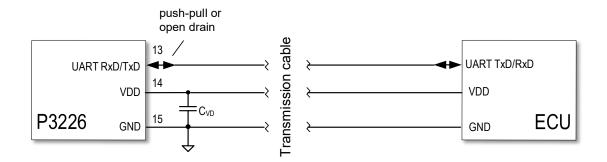


Figure 16. UART Point-to-Point Single Wire Bidirectional Connection

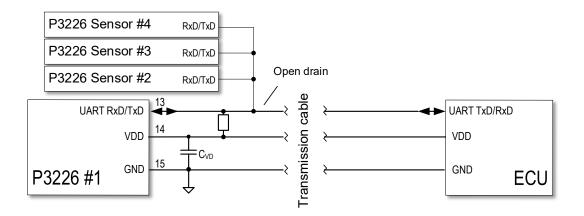


Figure 17. UART Multi-Slave Single Wire Bidirectional Connection

^[1] Maximum data rate may be reduced by external capacitive and resistive loads when open drain configuration is used.

5.1.2 Dual Wire Bidirectional UART with Pseudo-Differential TX

In dual wire UART mode, the device uses both OUT1 and OUT2 pins for communication. A point-to-point connection can be implemented as shown in Figure 16. This communication mode employs OUT1 as a single wire transceiver. (Figure 18).

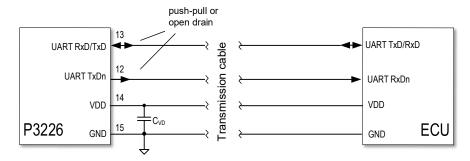


Figure 18. UART 2-Wire Point-to-Point Connection with Pseudo-Differential TX

In addition, OUT2 (pin 12) is used as the transmitter and OUT1 (pin 13) is used for both transmitting and receiving. OUT1 carries inverted information of the transmitted data, creating a pseudo differential signal for more reliable data transmission. During reception, OUT1 is kept in high state.

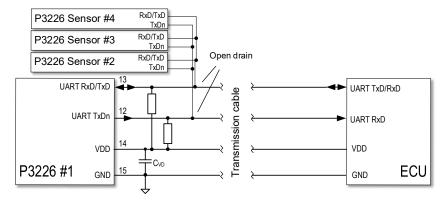


Figure 19. UART 2-Wire Connection with Pseudo-Differential TX and Multiple Slaves

In pseudo-differential mode, with open drain configuration, a single Master can address up to four sensors, communicating with one sensor at a time. Each sensor is identified by its slave address, stored in the NVM.

5.1.3 Dual Wire Unidirectional UART

In this dual wire mode, separate unidirectional lines are used for transmitting and receiving data. The transmitter can be configured either for push-pull or open-drain output. Push-pull mode is recommended for achieving data rates up to 2Mbit/s. In open-drain mode, data rates may be limited, depending on the capacitive load on the transmission cable and the resistance of the pull-up resistor.

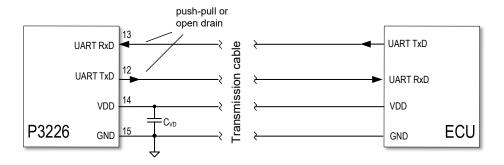


Figure 20. UART 2-wire Unidirectional Connection

In dual wire unidirectional mode, a single Master can address up to four sensors, communicating with one sensor at a time. Each sensor is identified by its slave address in the NVM. When connecting multiple sensors in parallel on the same line, the transmitter output (TxD) must be configured for open drain output.

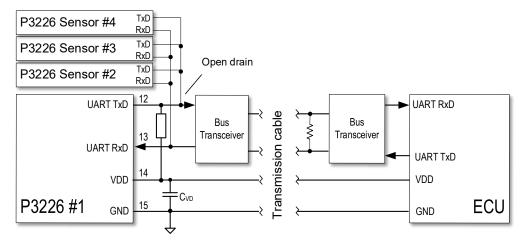


Figure 21. UART 2-Wire Unidirectional Connection with Multiple Slaves and Bus Transceivers

The transmission cable can be extended with external bus transceiver circuits as shown in Figure 21, providing extra robustness and low capacitive load for the UART TxD output pin, enabling high data rates up to 1Mbit/s.

5.1.4 UART Operating Commands

The RAA2P3226 provides the following UART operating modes:

- 16-bit register write (Figure 22)
- 16-bit register read (Figure 23)
- Fast read mode of two registers within one frame with 12,14 or 16 bits of data per register

5.1.4.1 Gap Time

A minimum pause (gap) time is implemented between messages to ensure the controller returns to an idle state before the next communications. The minimum gap time for each UART baud rate configuration is shown in Table 19.

Table 19. UART Wait Time between Measurements

| UART Baud Rate [bits/sec] | Minimum Gap Time [bits] | | |
|-----------------------------|-------------------------|--|--|
| 9600, 57600, 115200, 230400 | 10 | | |
| 1M, 2M | 12 | | |

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5.1.4.2 UART Register Write

This mode writes one register per frame. Each frame consists of 8 bytes, each accompanied by a start and stop bit, resulting in 8x10bits. A short wait (gap) time is required between each frame to ensure proper data transmission. The frame structure permits write access for all bytes, with the data being transmitted from the master to the chip.

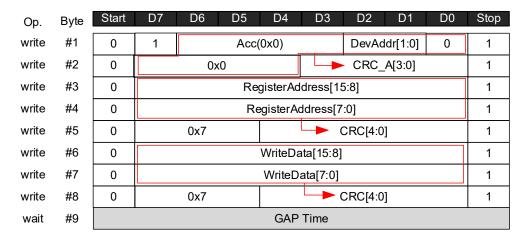


Figure 22. UART Register Write Mode

See the write frame structure on Figure 22 where:

- Acc: Access type 0x0 for register write.
- DevAddr: the device address if several sensors are connected in parallel, it defines their slave address (0x1-0x3) Default value is 0x0.
- Register Address: The target register.
- Write Data: The data to be written.
- CRC: Cyclic redundancy check.

5.1.4.3 UART Register Read

In read mode, the device reads one register per frame. The first 5 bytes are sent from master to the chip, while on bytes 6 to 8 are read from the chip. In all modes, the bit order is MSB to LSB. Each read frame contains 8 bytes, each with a start and stop bit, resulting in 8x10 bits. A short wait (gap) time is required between each frame.

For performing a data read operation, due to the generation of the differential start and stop bits, an additional wait bit must be added by the master when switching from sending data to receiving data. This results in each frame containing either 91 bits (for data rates up to 230.4 kbit/s) or 93 bits (for 1Mbit and 2Mbit data rates).

In register read mode, an additional wait bit must be added at the end of byte 5 before the chip can start transmitting data (start bit of byte 6). The *ReadData* content is latched at the stop bit of byte 5.

To ensure the accurate reading of high-resolution data, it is essential to begin by reading hires_lsb register first. This operation locks hires_msb that needs to be read subsequently.

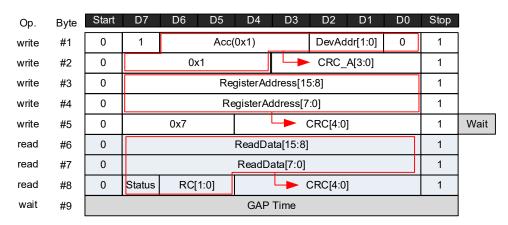


Figure 23. Register Read Mode Frame

See the read frame structure on Figure 23 where:

- Acc: Access type 0x1 for register read.
- DevAddr: the device address if several sensors are connected in parallel, it defines their slave address (0x1-0x3) Default value is 0x0.
- Register Address: the target register.
- Read Data: the data contents of the target register.
- CRC: cyclic redundancy check.
- Status: 1 bit status flag information of the sensor (0: normal operation, 1: error)
- RC: rolling counter, a counter that increments with each frame and wraps around 0 when overflowing.
- Wait: 1 bit wait time for master before receiving data (in pseudo-differential mode only).

5.1.4.4 UART Fast Two-Register Read

This mode enables a fast reading of a specific subset of two registers within each frame. The first two bytes of the frame allow the user to specify which subset of the two pre-defined registers to read, using a 4-bit access code. This is achieved by setting the access type on the *Acc1* and *Acc2* bitfields (see Table 20). The readout data for the first register is contained in bytes 3 to 5 while bytes 6 to 8 contain the data for the second register.

Acc Type1/2 Byte 3 / Byte 6 Byte 4 / Byte 7 Byte 5 / Byte 8 2 PC sensor Data[11:4] PC sensor Data[3:0] RC[5:2] S RC[1:0] CRC[4:0] SC sensor Data[11:4] CRC[4:0] SC sensor Data[3:0] RC[5:2] RC[1:0] 3 S 4 PC sensor Data[13:6] PC sensor Data[5:0] RC[3:2] S RC[1:0] CRC[4:0] 5 SC sensor Data[13:6] SC sensor Data[5:0] RC[3:2] S RC[1:0] CRC[4:0] 6 (ACC1) HiRes LSB [13:6] HiRes LSB [5:0] RC[3:2] S RC[1:0] CRC[4:0] 6 (ACC2) HiRes MSB[4:0] 0x0 RC[3:2] S RC[1:0] CRC[4:0] Chip temperature 0x0 RC[5:2] S RC[1:0] CRC[4:0] Analog input [12:5] Analog input [4:0] 0 RC[3:2] S RC[1:0] CRC[4:0] 8 PWM input data high 9 PWM input data high [7:0] S RC[1:0] CRC[4:0] [15:8] PWM input data low 10 = 0xAPWM input data low [7:0] S RC[1:0] CRC[4:0] [15:8] IRQ status 0 [15:8] 11 = 0xBIRQ status 0 [7:0] S RC[1:0] CRC[4:0] 12 = 0xCIRQ status 1 [15:8] IRQ status 1 [7:0] S RC[1:0] CRC[4:0] IRQ status 2 [7:0] 13 = 0xDIRQ status 2 [15:8] S RC[1:0] CRC[4:0] 14 = 0xEIRQ status 3 [15:8] IRQ status 3 [7:0] S RC[1:0] CRC[4:0] 15 = 0xFIRQ status 4 [15:8] IRQ status 4 [7:0] RC[1:0] CRC[4:0]

Table 20. UART Fast Access Mode

^[1] PC: Primary coil, SC: Secondary coil, RC: Rolling counter, HiRes: High resolution mode

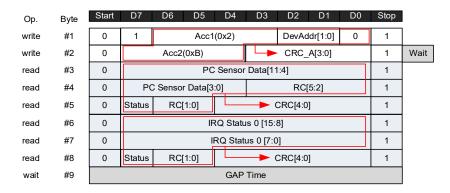


Figure 24. UART Fast Read Mode Example with Different Access Codes

See the frame structure on Figure 24 with an example of reading 12-bit primary coil sensor data (Acc1 = 0x2) and 16-bit IRQ status 0 (Acc2 = 0xB), the frame bitfields are the following:

- Acc1, Acc2: Access code: 0x2 to 0xF (see Table 20)
- DevAddr: Device address: (default = 0x0. If several sensors are connected in parallel, it defines their slave address (0x1-0x3).
- CRC: Cyclic redundancy check.
- Status: 1 bit status flag information of the sensor (0: normal operation, 1: error)
- ReadData: the data answer from the IC are the PC Sensor Data + RC for Byte #3 and #4 according to ACC1=0x2, while for ACC2=0xB the device provides IRQ_Status on Byte#6 and #7. (See Table 20).
 The ReadData is latched at the stop bit of Byte#2 for Acc1, and at the stop bit of Byte#5 for Acc2.
- RC: Rolling counter, a counter that increments with each frame and wraps around 0 when overflowing
- Wait: 1 bit wait time for master before receiving data (in pseudo-differential mode only)

In fast read mode, an additional wait bit must be added at the end of byte 2 before the device can start transmitting data.

5.1.4.5 UART Fast Read Mode with Same Access Code

Reading the same register twice provides two results from the same input but at different sampling time stamps. For example, in the configuration shown in Figure 25, the primary coil sensor data is read twice. The first reading (Acc1= 0x2) is sampled at the end of Byte 2, while the second reading (Acc2 = 0x2) is sampled at the end of Byte 5. The interval between these two results is 30 bits of the UART clock (3 bytes, including start and stop bits).

By repeating this sequence, the user can obtain two samples within a 92-bit frame. The timeframe between each consecutive sample is 30 UART clock cycles resulting in 15µs at 2M/s Baud rate. However, the time between each frame is 46µs at the same Baud-rate.

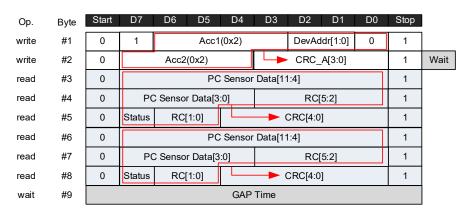


Figure 25. UART Fast Read Mode of the Same Register

5.1.4.6 High Resolution Mode Data

The device can provide high-resolution position information up to 19 bit. This requires two readings from the same access type (Acc = 0x6), split into the 14 LSBs and the 5 MSBs of the 19-bit data. In this mode, Bit D0 in byte 1 must be set to 0. The position is latched at the stop bit of Byte 2.

Both *Acc1* and *Acc2* must be set for access type 0x6. Bytes 3 to 8 transmit the full high resolution information including CRC and status bits.

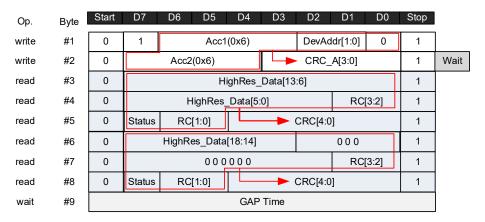


Figure 26. UART Fast Mode: High Resolution Position Information

Refer to Table 21 for a summary of the UART interface speed, based on the selected Baud rate and mode. Note that one frame can perform various operations such as register read, register write, or two consecutive register read (fast read).

Refer to Table 20 for a summary of the UART interface speed, based on the selected Baud rate and mode. Note that each frame can perform various operations such as register read, register write, or two consecutive register reads (fast read).

| UART Baud rate [bits/sec] | Bits per Frame | Time per Frame | Frame Rate | |
|---------------------------|------------------|----------------|--------------|--|
| • • | (incl. Gap Time) | [µs] | [frames/sec] | |
| 9600 | 91 | 9479.4 | 105.5 | |
| 57600 | 91 | 1580 | 633 | |
| 115200 | 91 | 789.9 | 1265 | |
| 230400 | 91 | 395 | 2532 | |
| 1M | 93 | 93 | 10.75 k | |
| 2M | 93 | 46.5 | 21.5 k | |

Table 21. UART Data Access Speed with uart_start_bit_cfg = 0

5.2 I2C Interface

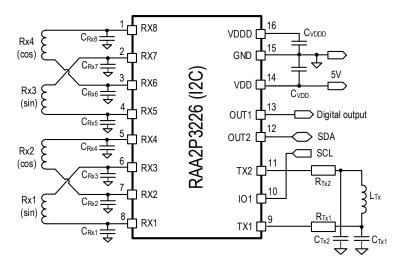


Figure 27. I2C Interface Input/Output Pins

The RAA2P3226 can be programmed for an I2C interface according to the UM10204 I2C-bus specification, utilizing pins 10 (SCL) and 12 (SDA) to address up to 14 slaves over the same 2-wire interface. The interface does not support clock stretching, 10-bit slave address, general call address, software reset, or device ID.

5.2.1 I2C Addressing

In RAA2P3226, two sets of receiver coils are connected. Pins 2 and 3 are used as coil inputs for the secondary coil set, therefore the hardware address selection on these two pins is not available.

If two devices are mounted on the same PCB sharing the same I2C bus, they initially share the same I2C address and cannot be addressed individually by the I2C bus master. To resolve this, the devices must be reprogrammed to different I2C addresses.

This can be accomplished by initially enabling single coil inputs and hardware I2C address selection. Individual I2C addresses are set temporarily by forcing the address inputs ADR0 (Pin 2) and ADR1 (Pin 3) of each device to different combinations of VDD or GND (pin strapping). The status of these pins is reflected in I2C Address Bits (see Table 23).

For example, as shown in Figure 28, one device is pin strapped to I2C address 0x72, while the other is pin strapped to address 0x70. Once each device is separately selected, it can be re-programmed for dual coil inputs and unique NVM I2C address.

| I2C Programming Parameter | Number of Options | Programming Option |
|-------------------------------------|-------------------|-------------------------|
| I2C slave address | 14 | See Table 23 |
| I2C address select by pin strapping | 1 | Enable/Disable (2 LSBs) |
| I2C CRC check for Rx data | 1 | Enable/Disable |
| I2C CRC check for command data | 1 | Enable/Disable |
| I2C protocol error detection | 1 | Enable/Disable |

Table 22. I2C Interface User Programming Options

Refer to Table 23 for the various options available for selecting the I2C address. This can be achieved through combinations of pin addressing and settings in the NVM address register.

| I2C Address Selection Mode | A6 | A5 | A4 | А3 | A2 | A1 | A0 |
|---|-------------------------------------|----|--------------|--------------|--------------|----|----|
| Default setting | 1 1 1 0 0 | | Pin 3 = ADR1 | Pin 2 = ADR0 | | | |
| User programmable range, with I2C address selection by pins 2 and 3 | 0x02 to 0x1D Pin 3 = ADR1 Pin 2 = A | | | | Pin 2 = ADR0 | | |
| User programmable range, with fixed I2C address | 0x08 to 0x77 | | | | | | |

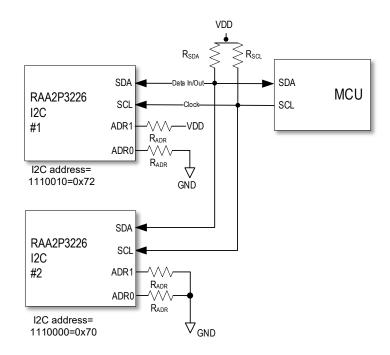


Figure 28. I2C Interface with Address Select

5.2.2 I2C Register Write

To access a register, the slave address must be sent by the master, followed by two bytes of register address (*MemAddr*), one byte of CRC data, and then by the write data *WrData*. If the CRC check is disabled, keep the CRC frame at zero. The write data consists of two bytes of data followed by one byte of CRC data as shown in Figure 29.

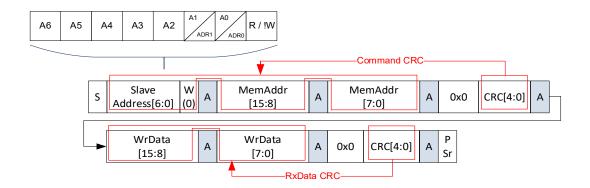


Figure 29. I2C Register Write Access

5.2.3 I2C Register Read

To read a register over the I2C interface, the master sends a write register command frame followed by a repeated start (*PSr*) and slave address with a read bit set. Upon acknowledgement, the device responds with two bytes of data followed by one byte CRC as shown in Figure 30.

The high-resolution on-chip calculation mode is not available with I2C interface. The angle of coil1 and coil2 must be accessed separately.

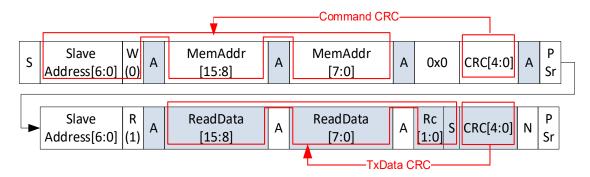


Figure 30. I2C Register Read Access

5.2.4 I2C CRC Check

For optimal communication with the RAA2P3226, it is recommended to enable the CRC check for I2C communication. Enabling it ensures that the device only responds to command frames that include correct CRC data. For more details, see the RAA2P3226 Programming Manual document.

5.3 Incremental Interfaces

The RAA2P3226 features incremental interfaces (ABI, Step/Direction), making it ideal for replacing optical and magnetic encoders in industrial applications. Both interfaces use three channels on OUT1, OUT2 and IO1 pins, as shown in Figure 31.

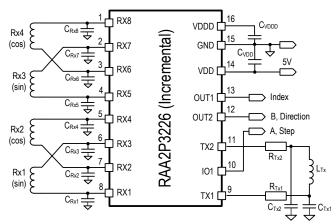


Figure 31. Incremental Interfaces Input/Output Pins

Table 24. Incremental Interfaces Programming Options

| Programming parameter | Number of options | Programming option |
|-----------------------|-------------------|--|
| Incremental mode | 2 | ABI, Step/Direction |
| Index pulse length | 2 | For ABI and Step/Direction mode: 1 LSB, 3 LSBs |
| Index pulse position | 4 | For ABI and Step/Direction mode |

| Programming parameter | Number of options | Programming option |
|-------------------------------|-------------------|--|
| Startup counter burst mode | 5 | Burst generator disabled |
| Startup counter burst mode | 5 | If enabled: Frequency of startup burst generator (4) |
| Startup counter wait time | 4 | If enabled: wait time of burst generator after POR |
| Type of interpolation mode | 2 | Binary, decimal |
| Incremental resolution | 4 | Pulses per revolution or counts per revolution, see Table 25 |
| High resolution absolute mode | 4 | 4/8/16/32 periods on primary coil |

5.3.1 ABI Interface

In ABI interface decoding, the A and B channels operate in quadrature, toggling a 50% duty cycle, while the I (Index) signal pulses once per revolution to mark the zero-angle position. Each cycle of the quadrature signals A and B contains four distinct states, facilitating precise counting and direction determination.

The counting mechanism increments or decrements the count by four per cycle, corresponding to the edges of channels A and B. As a result, the counts per period is four times higher than the number of pulses per period. Counting direction of the receiving counter is determined by the state of the channels at each edge. During clockwise rotation, a rising edge of channel A occurs when channel B is low. Conversely, during counterclockwise rotation, the rising edge of channel A occurs when channel B is high. RAA2P3226 also allows for the reversal of rotational direction via programming, providing flexibility to meet different application requirements.

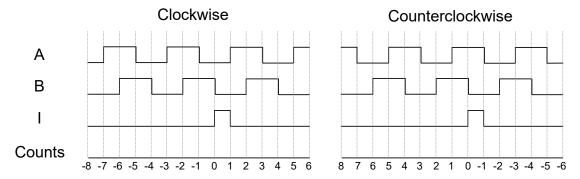


Figure 32. ABI Protocol

5.3.2 Step-Direction

RAA2P3226 can be configurable for Step-Direction protocol, in which one pin (Step) delivers one pulse per count, while the other pin (Direction) is kept high or low according to the rotational direction. As a result, the Step pin delivers double the number of pulses compared to the A pin in ABI mode.

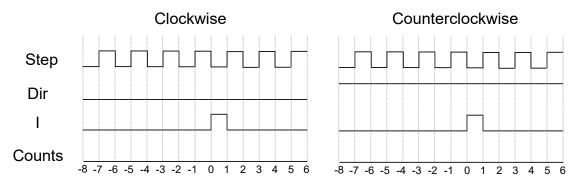


Figure 33. Step-Direction Protocol

5.3.3 Interpolator Factor/Resolution

The incremental interfaces for the RAA2P3226 device feature four interpolation factor settings (9-bit,10-bit,11-bit,12-bit), available in both binary and decimal formats. The interpolation factor is defined as the number of counts per electrical period. "Pulses per period" refers to the number of pulses generated on one channel over one electrical period (360° el.). The interpolator settings define the number of counts per electrical period, which must be multiplied by the number of primary coil periods to calculate the number of counts per mechanical period as shown in Table 25.

The maximum achievable resolution on ABI interface is 17-bit, which can be obtained by configuring 32 periods on the primary coil and utilizing the 12-bit interpolator. This configuration divides each mechanical period into 131072 counts.

| Primary Coil | Primary Coil Binary | | | Decimal | | | | |
|--------------|---------------------|-------------------|-------------------|--------------------|-------|--------|--------|--------|
| [Periods] | 9-bit | 10-bit | 11-bit | 12-bit | 9-bit | 10-bit | 11-bit | 12-bit |
| 4 | 2048 (11-bit) | 4096 (12-bit) | 8192 (13-bit) | 16384 (14-bit) | 2000 | 4000 | 8000 | 16000 |
| 8 | 4096 (12-bit) | 8192 (13-bit) | 16384 (14-bit) | 32768 (15-bit) | 4000 | 8000 | 16000 | 32000 |
| 16 | 8192 (13-bit) | 16384 (14-bit) | 32768 (15-bit) | 65536 (16-bit) | 8000 | 16000 | 32000 | 64000 |
| 32 | 16384 (14-bit) | 32768 (15-bit) | 65536 (16-bit) | 131072 (17-bit) | 16000 | 32000 | 64000 | 128000 |

Table 25. Counts per Mechanical Period and Resolution by Interpolator/Primary Coil settings

5.3.4 Maximum Speed

The maximum rotation speed is defined by the maximum output pulse rate at channels A and B, which is 2MHz. Additionally, the maximum rotation speed depends on the interpolator resolution and the number of pole pairs of the primary coil.

| Primary Coil | | Interpolator settings [rpm] | | | | | | |
|--------------|----------------|-----------------------------|------------------|------------------|--|--|--|--|
| [Periods] | 9-bit [512] | 10-bit [1024] | 11-bit [2048] | 12-bit [4096] | | | | |
| 4 | 150000 | 117000 | 58000 | 29000 | | | | |
| 8 | 75000 | 58000 | 29000 | 15000 | | | | |
| 16 | 37000 | 29000 | 15000 | 7300 | | | | |
| 32 | 18000 | 15000 | 7300 | 3700 | | | | |

Table 26. Maximum Mechanical Rotational Speed by Interpolator Setting

5.3.5 Index Pulse

Encoders' incremental interfaces send an index pulse to mark their zero position. The receiver uses this pulse to synchronize and subsequently utilize use the A/B and Step/Direction signal to maintain accurate position tracking. The index pulse width and position are programmable to support a wide range of receivers.

Two programmable options for the index pulse width are available: 1 count or 3 counts duration. Furthermore, there are four programmable options for the index pulse position (index_cfg), each defining the resulting diagnostic state as described in Table 27.

| Index Pulse Position | ABI Diagnostic State | Step/Dir Diagnostic State |
|----------------------|----------------------|---------------------------|
| A=0 B= 0 | A=1, B=1, I=1 | Step=1, Dir=X , I=1 |
| A=1 B= 1 | A=0, B=0, I=1 | Step=0, Dir=X , I=1 |
| A=0 B=1 | A=0, B=0, I=1 | Step=1, Dir=X , I=1 |
| A=1 B=0 | A=0, B=1, I=1 | Step=0, Dir=X, I=1 |

Table 27. ABI Index Configurations

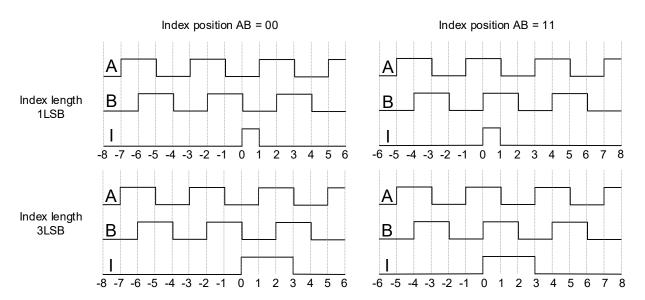


Figure 34. ABI Index Position and Length Configurations

The index configuration defines the diagnostic state indication. The combination of the three signals in Diagnostic Mode is the one that does not occur during normal operation.

5.3.6 True-Power-On Absolute Position Information

Incremental interfaces lack the capability to deliver absolute position information immediately upon power-up. At power-up, the absolute position remains unknown if the measured object, such as a motor, is stationary. Motion is required to detect the first index and calculate the position accurately.

RAA2P3226 is capable of calculating the absolute position internally and provides it over the incremental interface after power-up, before any rotation starts. This is implemented by sending an artificial burst of pulses (see Figure 35).

After a programmable wait time, an index pulse is generated to reset the external counter at the receiving end, followed by a series of AB pulses that indicate the absolute position. The frequency of this pulse train is programmable, ensuring synchronization of the counter at the receiving end with the correct absolute position. The rotor must remain stationary during the initial pulse train sequence. This feature can be enabled or disabled by user programming.

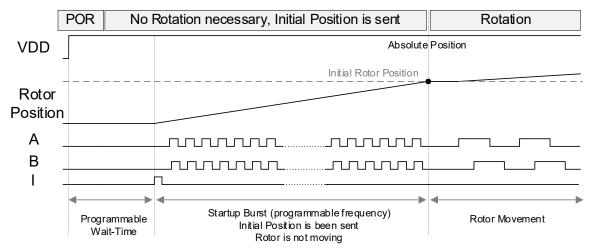


Figure 35. ABI True-Power-On Burst Delivering Absolute Position at Startup Without Rotation

5.3.7 Hysteresis

To prevent jitter in the position output when the system is stationary due to noise, hysteresis is implemented. If the rotational direction remains unchanged, hysteresis has no effect. It becomes noticeable when the rotational direction is reversed, see Figure 36. In such case, the indicated position in the opposite direction is offset by the selected amount of hysteresis. The hysteresis is programmable in 8 steps.

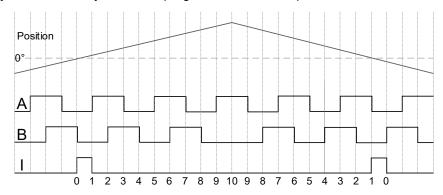


Figure 36. ABI Reversing Direction

5.4 UART Single Wire Programming Interface

Any user programmable parameter can be accessed through the single wire programming process, using a half-duplex UART protocol.

When performing an end-of-line calibration or in-line programming of a position sensor module containing the RAA2P3226, no additional wires are required. The chip is programmed through the OUT1 output at the operational supply voltage range (5V ±10%, 3.3V ±10%).

A short programming window is enabled after POR and requires a digital unlock password to activate programming mode. If no password is sent, the chip resumes its normal operating mode.

For more details, see the RAA2P3226 Programming Manual document.

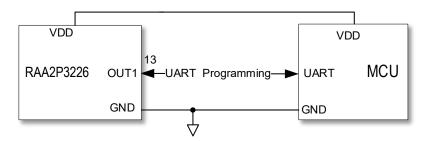


Figure 37. UART Single Wire NVM Programming

5.4.1 Lock Feature

The RAA2P3226 includes a lock bit feature that can be configured by the user. The lock feature allows for both write and read lock options. Once the corresponding lock bits are set, no further writing or reading to/from the RAA2P3226 is possible. It is important to note that a locked RAA2P3226 cannot be unlocked. For more details, see the *RAA2P3226 Programming Manual* document.

6. Auxiliary Inputs and Outputs

One auxiliary input is available for connecting external devices with UART interface. Further, a digital output pin is available indicating user programmable features. A summary is shown in Table 28.

| Interface | Analog Input | Register Flag (Open-Drain) |
|----------------|--------------|----------------------------|
| 1-wire UART | Yes (pin 10) | Yes (pin 12) |
| 2-wire | Yes (pin 10) | n/a |
| I2C | n/a | Yes (pin 13) |
| ABI – Step/Dir | n/a | n/a |

Table 28. Auxiliary Inputs and Digital Output Options

6.1 Analog Input

An analog input available on pin 10 (IO1) in UART mode and can be used to read buffered analog voltages from external sensors. See Table 29 for the key parameters of this input. The analog value must be in relation to VDDD.

| Symbol | Parameter | Conditions | Minimum | Typical | Maximum | Units |
|----------------------|--------------------------|------------|---------|---------|---------|-------|
| V _{IN_AIN} | AIN voltage range | | 0.1 | | 1.2 | V |
| RES _{AIN} | ADC resolution | | | 12 | | bits |
| T _{Smp_AIN} | Sampling rate | | 4.4 | | | kHz |
| ACC _{AIN} | Analog Input Accuracy | | -1.5 | | 1.5 | %VDDD |

Table 29. AIN Analog Input Parameters

Both the analog input and the VDDD reference voltages are internally measured and stored in registers. The external load on VDDD cannot exceed 4 mA as specified in Table 4

6.2 Digital Output (Register Flag)

An optional digital output is available in UART and I2C mode. In this configuration, the DOUT output can be used to drive external circuits. DOUT is available on OUT2 pin for UART configuration, on OUT1 pin for I2C. It is controlled by writing either of the following options to the address 0x029E [0]:

- Register bit 0: FLG output is low
- Register bit 1: FLG output is high

This function can be integrated with a heartbeat feature to provide diagnostic status information alongside the flag value. This status is indicated by a 1.5KHz pulse, see Figure 38 with a duty cycle of 97% when the flag is high and 3% when the flag is low.

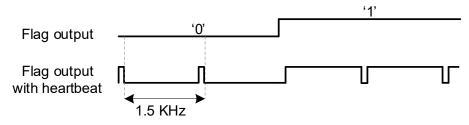


Figure 38. Flag Output Configurations

7. On-Chip Diagnostics

The RAA2P3226 includes on-chip diagnostics featuring an extensive number of internal diagnostic monitors (DM). For detailed description, see the *RAA2P3226 Programming Manual* document.

.

Table 30. Diagnostic Parameters

| Symbol | Parameter | Conditions | Minimum | Typical | Maximum | Units |
|-------------------|---|------------|---------|---------|---------|-------|
| T _{FDTI} | Failure detection time interval | fdti_cfg=1 | | | 2.3 | ms |
| | (time to detect and internally set a flag describing the error condition) | fdti_cfg=0 | | | 20 | ms |

Table 31. Diagnostic Monitors

| 0-1 | Diagnostic Monitors | Page 31. Diagnostic Monitors |
|---|---|---|
| Category | (DM) | Description |
| Monitoring of external supply | VDD Monitor | External VDD supply out of range |
| | VDDA Monitor | Internal VDDA (Analog supply) out of range / undervoltage /overvoltage |
| | | Internal VDDD (Digital supply) out of range |
| | VDDD Monitor | Short on VDDD |
| | | Overcurrent at VDDD pin |
| Monitoring of | Internal Supply Monitor | Internal supply out of range |
| internal | Internal pre-regulators | Internal pre-regulator for power management (bandgap, analog parts) out of range |
| supplies | Monitor | Internal pre-regulator for output stages out of range |
| | Driver Regulator Monitor | OUT2 regulator driver out of range |
| | Oscillator Regulator | <u> </u> |
| | Monitor | LC oscillator regulator out of range |
| | Bias Current Monitor | Bias current diagnostic out of range |
| | RX coil Sine Monitor | Short of the RX vs GND or VDD |
| | (Primary and Secondary) | Broken wire detected on RX SIN |
| Monitoring of RX coils | RX coil Cosine Monitor | Short of the RX vs GND or VDD |
| NA COIIS | (Primary and Secondary) | Broken wire detected on RX COS |
| | RX coil Sine/Cosine neighbor inputs short | Short check between Sine/Cosine coil set detected |
| | TX Voltage Monitor | Common mode voltage of TX1/TX2 out of range |
| Monitoring of | 17 Voltage Monitor | Flag for broken pins of LC oscillator |
| TX coils | LC Oscillator Monitor | LC oscillator stuck detected |
| | | LC oscillator frequency out of range |
| Monitoring of | System clock Monitor | Fault in internal system clock: frequency out of range |
| system clock | | Fault in internal system clock: stuck detected |
| Monitoring of the internal communication channel | Internal digital logic failure Monitor | Internal digital logic failure detected such as APB Diagnostic failure, IC internal registers failure, FSM failure, CORDIC failure, other digital failures. |
| Monitoring the | Non-Volatile Memory | CRC mismatch over the NVM or internal shadow register |
| internal memory | Monitor | NVM read timeout fail |
| Data path diagnostics | Data path WD/OF/UF/DO Monitor | Internal errors, such as overflow, underflow, division by 0, or watchdogs |
| Position Range Monitoring | Position Range Monitor | Position outside of the defined range failure |
| Temperature | Temperature Monitor | Temperature warning detected |
| monitoring | 1 Simporature Monitor | Temperature error (shutdown) detected |

| Category | Diagnostic Monitors (DM) | Description |
|---|--|--|
| Magnitude evaluation | Magnitude static Monitor | Magnitude static check error detected on RX coils |
| Monitoring of analog signal path offset | ADC temperature sensor offset fail Monitor | Compensation of the internal offset not sufficient |
| Monitoring of the mechanical stress /cracks | Broken chip check Monitor | IC die mechanical failures detected |
| LPF check for signal path | LPF Monitoring | Failure in internal LPF |
| AGC monitoring | C monitoring AGC error Monitoring | Automatic gain control loop not converging Pre-defined acceptable gains for the AGC not sufficient for RX |
| Monitoring of the output interfaces | Output Interfaces monitors | Failure of the I2C interfaceFailure of the UART interface |
| Analog input | Analog Input Monitoring | Failure on analog input range |
| OUT2 and IO1 pins monitoring | OUT2/IO1 pins Monitoring | Overvoltage/undervoltageShort on OUT2/IO1 detection |

A fault from a broken or short wire refers to the connection between sensor IC and control unit (MCU, ECU), including the soldering of the IC pins, PCB traces, connectors and cables. In this case, the diagnostic state depends on whether pull-up/pull-down resistors are installed at the receiver side.

8. User Programming Options

Table 32 shows an extract of the main configuration options. A detailed description is provided in the RAA2P3226 programming manual, available on request from Renesas.

Table 32. Global Programming Options, RAA2P3226

| Programming Option | Number of options | Description |
|--|-------------------|---|
| Power supply mode | 2 | 3.3V ±10% or 5.0V ±10% |
| Interface Options | 4 | UART, I2C, ABI, Step/Dir |
| Initial receiver gain, primary and secondary coils | 2 x 27 | Initial receiver gain |
| Automatic gain control AGC | 2 | Enabled/disabled |
| Hysteresis | 2 x 8 | 0 to 112 LSBs |
| Number of linearization points | 16 points | Up to 16 linearization points are freely programmable on primary and secondary coil |
| Linearization points resolution | 12-bit | Up to 16 linearization points are freely programmable in X (position) and Y (value) with 12-bit resolution |
| Magnitude alarm reference limits | 2 x 14-bit | Upper and Lower limits programmability |
| Zero (discontinuity) point for primary and secondary coils | 2 x 12-bit | 0° to <360° in 12-bit steps, position output switches from maximum to minimum value (with increasing position movement) or from minimum to maximum value (with decreasing position movement) at this position |
| Sine and cosine signal offset correction | 4 x 8-bit | ±127 LSBs for sine/cosine for primary and secondary coils |

| Programming Option | Number of options | Description |
|---|-------------------|---|
| Sine and Cosine amplitude mismatch correction on primary and secondary coil | 4 x 15-bit | 0% to 199% adjustment range per channel |
| Digital low pass filter on primary and secondary coil | 2 x 8 | Depth of digital low pass filter for primary coil position output |
| Turns counter for primary and secondary coil | 2 x 12-bit | Behavior of 12bit primary coil turns counter when overflowing: stop at max/min, wrap around |
| Customer ID | 48-bit | Scratchpad register for customer specific data |

9. Related Documents

RAA2P3226 Programming Manual

10. 16-TSSOP Package Outline Drawings

The package outline drawings are accessible from the link below. The package information is the most current data available.

16-TSSOP Package Outline Drawing 4.4mm Body, 0.65mm Pitch PGG16T1

11. Marking Diagram

RAA2P 3226E4G LOT YYWW R Line 1: First characters of part code: RAA2P.

Line 2: Next five characters of the part code:

3226E: Dual Coil High Speed

followed by:

4 = Operation temperature range, Industrial

G = Industrial Qualified

Line 3: "LOT" = Lot number

Line 4: "YYWW" = Manufacturing date: YY = last two digits of manufacturing year

WW = manufacturing week

R = RoHS compliant statement

12. Ordering Information

| Orderable Part Number | Description and Package | MSL Rating | Carrier Type | Temperature |
|-----------------------|-------------------------|---------------|----------------------------|----------------|
| RAA2P3226E4GSP#HA0 | 16-TSSOP, 4.4 ×5.0 mm | 3 | 7" Reel, 1300 parts / reel | -40° to +125°C |

For communication and programming, Renesas offers a RAA2P3226 Application Modules with a RAA2P-COMBOARD. A development programmer is available separately.

13. Glossary

| Term | Description | |
|-------|---|--|
| ADC | Analog to Digital Converter | |
| BLDC | Brushless Direct Current | |
| DC | Direct Current | |
| DP | Discontinuity Point | |
| GND | Ground | |
| IC | Integrated Circuit | |
| LF | Low Frequency | |
| OD | Open Drain | |
| PCB | Printed Circuit Board | |
| Pk-pk | Peak to peak | |
| PP | Push-Pull | |
| UART | Universal Asynchronous Receiver / Transmitter | |
| RF | Radio Frequency | |
| RX | Receiver | |
| TX | Transmitter | |

14. Revision History

| Revision | Date | Description |
|----------|-------------|--|
| 1.1 | Dec 8, 2025 | Reworked Table 5. Table 13, Table 7, Sections 5, 5.2.3, Cover page |
| 1.0 | Aug 7, 2025 | Initial release |

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